Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/825,202	HARAGUCHI ET AL.		
Examiner	Art Unit		
Tae H. Yoon	1714		

SEARCHED			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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